













## OPA196, OPA2196, OPA4196

SBOS869 - JULY 2017

## OPAx196 36-V, Low-Power, Low Offset Voltage, Rail-to-Rail Operational Amplifier

## 1 Features

- Low Offset Voltage: ±100 μV (maximum)
- Low Offset Voltage Drift: ±0.5 μV/°C (typical)
- Low Bias Current: ±5 pA (typical)
- High Common-Mode Rejection: 140 dB
- Low Noise: 15 nV/√Hz at 1 kHz
- · Rail-to-Rail Input and Output
- Differential Input Voltage Range to Supply Rail
- · Wide Bandwidth: 2.5-MHz GBW
- Low Quiescent Current: 140 μA per Amplifier (typical)
- Wide Supply: ±2.25 V to ±18 V, 4.5 V to 36 V
- EMI/RFI Filtered Inputs
- High Capacitive Load Drive Capability: 1 nF
- Industry Standard Packages:
  - Single in SOIC-8, SOT-5, and VSSOP-8
  - Dual in SOIC-8 and VSSOP-8
  - Quad in SOIC-14, TSSOP-14, and QFN-16

## 2 Applications

- Multiplexed Data-Acquisition Systems
- · Test and Measurement Equipment
- High-Resolution ADC Driver Amplifiers
- SAR ADC Reference Buffers
- Analog Input and Output Modules
- High-Side and Low-Side Current Sensing
- High-Precision Comparator
- Medical Instrumentation

## 3 Description

The OPAx196 family (OPA196, OPA2196, and OPA4196) is a new generation of 36-V, rail-to-rail etrim<sup>™</sup> operational amplifiers (op amps).

These devices offer very low offset voltage ( $\pm 25~\mu V$ , typical), drift ( $\pm 0.5~\mu V/^{\circ}C$ , typical), and low bias current ( $\pm 5~pA$ , typical) combined with very low quiescent current (140  $\mu A$ /channel, typical) across the entire output range.

Unique features, such as differential input-voltage range to the supply rail, high output current (±65 mA), and high capacitive load drive of up to 1 nF make the OPAx196 a robust, high-performance operational amplifier for high-voltage industrial applications.

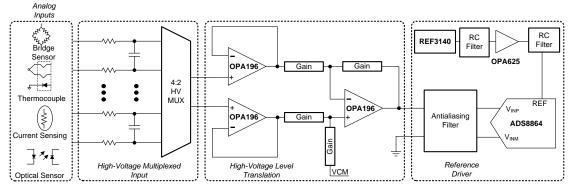
The OPAx196 family of op amps is available in standard packages and is specified from -40°C to +125°C.

#### Device Information<sup>(1)</sup>

| Bovios imerinación |            |                   |  |  |  |  |
|--------------------|------------|-------------------|--|--|--|--|
| PART NUMBER        | PACKAGE    | BODY SIZE (NOM)   |  |  |  |  |
|                    | SOIC (8)   | 4.90 mm × 3.90 mm |  |  |  |  |
| OPA196             | SOT (5)    | 2.90 mm × 1.60 mm |  |  |  |  |
|                    | VSSOP (8)  | 3.00 mm × 3.00 mm |  |  |  |  |
| OPA2196            | SOIC (8)   | 4.90 mm × 3.90 mm |  |  |  |  |
| UPA2196            | VSSOP (8)  | 3.00 mm × 3.00 mm |  |  |  |  |
| ODA 4406           | SOIC (14)  | 8.65 mm x 3.90 mm |  |  |  |  |
| OPA4196            | TSSOP (14) | 5.00 mm x 4.40 mm |  |  |  |  |

 For all available packages, see the package option addendum at the end of the data sheet.

## OPA196 in a High-Voltage, Multiplexed, Data-Acquisition System



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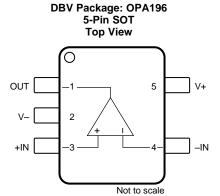
## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

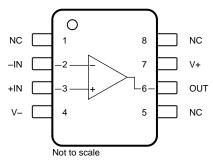
| DATE      | REVISION | NOTES           |
|-----------|----------|-----------------|
| July 2017 | *        | Initial release |



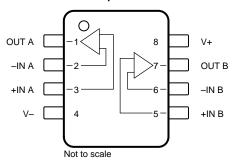
## 5 Pin Configuration and Functions



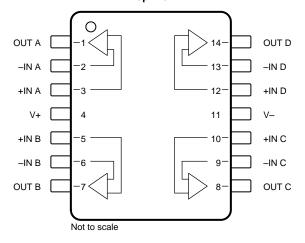
D and DGK Packages: OPA196 8-Pin SOIC and VSSOP Top View



#### D and DGK Packages: OPA2196 8-Pin SOIC and VSSOP Top View



#### D and PW Packages: OPA4196 14-Pin SOIC and TSSOP Top View



(1) NC = No internal connection.



## Pin Functions: OPA196

|      | PIN                      |           |     |   |  |  |
|------|--------------------------|-----------|-----|---|--|--|
|      | OPA196                   | OPA196    |     | DESCRIPTION                                   |  |  |
| NAME | D (SOIC),<br>DGK (VSSOP) | DBV (SOT) | I/O |   |  |  |
| +IN  | 3                        | 3         | I   | Noninverting input                            |  |  |
| -IN  | 2                        | 4         | I   | Inverting input                               |  |  |
| NC   | 1, 5, 8                  | _         | _   | No internal connection (can be left floating) |  |  |
| OUT  | 6                        | 1         | 0   | Output  |  |  |
| V+   | 7                        | 5         | _   | Positive (highest) power supply               |  |  |
| V-   | 4                        | 2         | _   | Negative (lowest) power supply                |  |  |

## Pin Functions: OPA2196 and OPA4196

|       | PIN                      |                         |     |                                 |
|-------|--------------------------|-------------------------|-----|---------------------------------|
|       | OPA2196                  | OPA4196                 | I/O | DESCRIPTION                     |
| NAME  | D (SOIC),<br>DGK (VSSOP) | D (SOIC),<br>PW (TSSOP) |     |                                 |
| +IN A | 3                        | 3                       | 1   | Noninverting input, channel A   |
| +IN B | 5                        | 5                       | 1   | Noninverting input, channel B   |
| +IN C | _                        | 10                      | I   | Noninverting input, channel C   |
| +IN D | _                        | 12                      | 1   | Noninverting input, channel D   |
| –IN A | 2                        | 2                       | 1   | Inverting input, channel A      |
| –IN B | 6                        | 6                       | 1   | Inverting input, channel B      |
| –IN C | _                        | 9                       | 1   | Inverting input,,channel C      |
| –IN D | _                        | 13                      | I   | Inverting input, channel D      |
| OUT A | 1                        | 1                       | 0   | Output, channel A               |
| OUT B | 7                        | 7                       | 0   | Output, channel B               |
| OUT C | _                        | 8                       | 0   | Output, channel C               |
| OUT D | _                        | 14                      | 0   | Output, channel D               |
| V+    | 8                        | 4                       | _   | Positive (highest) power supply |
| V-    | 4                        | 11                      |     | Negative (lowest) power supply  |



## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                               |                           |                           | MIN        | MAX                         | UNIT       |  |
|-------------------------------|---------------------------|---------------------------|------------|-----------------------------|------------|--|
| Supply voltage, $V_S = (V_S)$ | /+) - (V-)                |                           |            | ±20<br>(+40, single supply) | oply) V    |  |
|                               | Valtage                   | Common-mode               | (V-) - 0.5 | (V+) + 0.5                  |            |  |
| Signal input pins             | Voltage                   | Differential              |            | (V+) - (V-) + 0.2           | V          |  |
|                               | Current                   | Current                   |            | ±10                         | mA         |  |
| Output short circuit (2)      |                           |                           | Continuous | Continuous                  | Continuous |  |
|                               | Operating                 |                           | -40        | 150                         |            |  |
| Temperature                   | Junction                  |                           |            | 150                         | °C         |  |
| Output short circuit (2)      | Storage, T <sub>stg</sub> | Storage, T <sub>stg</sub> |            | 150                         |            |  |

<sup>1)</sup> Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Short-circuit to ground, one amplifier per package.

## 6.2 ESD Ratings

|                    |                         |         |   | VALUE | UNIT |
|--------------------|-------------------------|---------|---|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | OPAx196 | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)              | ±3000 | V    |
|                    |                         |         | Charged-device model (CDM), per JEDEC specification JESD22-C101 (2) | ±1000 | V    |
| V <sub>(ESD)</sub> |                         |         |   | ±500  | V    |
|                    | alconargo               | OPA4196 |   | ±500  | V    |

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                                     | MIN         | NOM MAX  | UNIT |
|-------------------------------------|-------------|----------|------|
| Supply voltage, $V_S = (V+) - (V-)$ | 4.5 (±2.25) | 36 (±18) | V    |
| Specified temperature               | -40         | 125      | °C   |

## 6.4 Thermal Information: OPA196

|                      |  |       | OPA196         |           |       |  |
|----------------------|--|-------|----------------|-----------|-------|--|
|                      | THERMAL METRIC <sup>(1)</sup>                | 8 1   | PINS           | 5 PINS    | UNIT  |  |
|                      |  |       | DGK<br>(VSSOP) | DBV (SOT) | O.u.i |  |
| $R_{\theta JA}$      | Junction-to-ambient thermal resistance       | 115.8 | 180.4          | 158.8     | °C/W  |  |
| $R_{\theta JC(top)}$ | Junction-to-case(top) thermal resistance     | 60.1  | 67.9           | 60.7      | °C/W  |  |
| $R_{\theta JB}$      | Junction-to-board thermal resistance         | 56.4  | 102.1          | 44.8      | °C/W  |  |
| ΨЈТ                  | Junction-to-top characterization parameter   | 12.8  | 10.4           | 1.6       | °C/W  |  |
| ΨЈВ                  | Junction-to-board characterization parameter | 55.9  | 100.3          | 4.2       | °C/W  |  |
| $R_{\theta JC(bot)}$ | Junction-to-case(bottom) thermal resistance  | N/A   | N/A            | N/A       | °C/W  |  |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



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## 6.5 Thermal Information: OPA2196

|                      |  | OP.      | OPA2196     |      |  |  |
|----------------------|--|----------|-------------|------|--|--|
|                      | THERMAL METRIC <sup>(1)</sup>                | 8        | 8 PINS      |      |  |  |
|                      |  | D (SOIC) | DGK (VSSOP) |      |  |  |
| $R_{\theta JA}$      | Junction-to-ambient thermal resistance       | 107.9    | 158         | °C/W |  |  |
| $R_{\theta JC(top)}$ | Junction-to-case(top) thermal resistance     | 53.9     | 48.6        | °C/W |  |  |
| $R_{\theta JB}$      | Junction-to-board thermal resistance         | 48.9     | 78.7        | °C/W |  |  |
| ΨЈТ                  | Junction-to-top characterization parameter   | 6.6      | 3.9         | °C/W |  |  |
| ΨЈВ                  | Junction-to-board characterization parameter | 48.3     | 77.3        | °C/W |  |  |
| $R_{\theta JC(bot)}$ | Junction-to-case(bottom) thermal resistance  | N/A      | N/A         | °C/W |  |  |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

## 6.6 Thermal Information: OPA4196

|                      |  | OPA      | A4196      |      |  |
|----------------------|--|----------|------------|------|--|
|                      | THERMAL METRIC <sup>(1)</sup>                | 14       | 14 PINS    |      |  |
|                      |  | D (SOIC) | PW (TSSOP) |      |  |
| $R_{\theta JA}$      | Junction-to-ambient thermal resistance       | 86.4     | 92.6       | °C/W |  |
| $R_{\theta JC(top)}$ | Junction-to-case(top) thermal resistance     | 46.3     | 27.5       | °C/W |  |
| $R_{\theta JB}$      | Junction-to-board thermal resistance         | 41.0     | 33.6       | °C/W |  |
| ΨЈТ                  | Junction-to-top characterization parameter   | 11.3     | 1.9        | °C/W |  |
| ΨЈВ                  | Junction-to-board characterization parameter | 40.7     | 33.1       | °C/W |  |
| $R_{\theta JC(bot)}$ | Junction-to-case(bottom) thermal resistance  | N/A      | N/A        | °C/W |  |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



## 6.7 Electrical Characteristics: $V_S = \pm 4 \text{ V to } \pm 18 \text{ V (}V_S = 8 \text{ V to } 36 \text{ V)}$

at  $T_A$  = 25°C,  $V_{CM}$  =  $V_{OUT}$  =  $V_S$  / 2, and  $R_L$  = 10 k $\Omega$  connected to  $V_S$  / 2 (unless otherwise noted)

|                      | PARAMETER  | TEST COM  | NDITIONS   | MIN                         | TYP        | MAX          | UNIT                        |
|----------------------|--|---|--|-----------------------------|------------|--------------|-----------------------------|
| OFFSET \             | VOLTAGE  |   |  |                             |            |              |                             |
| Vos                  | Input offset voltage   | V <sub>S</sub> = ±18 V  |  |                             | ±25        | ±100         | μV                          |
|                      |  | $(V+) - 3.0 V < V_{CM} < (V+) - 1.5 V$  |  | See Common-                 | Mode Volt  | age Range    |                             |
|                      |  | $V_S = \pm 18 \text{ V},$<br>$V_{CM} = (V+) - 1.5 \text{ V}$                      |  |                             | ±25        | ±100         |                             |
| D/ /IT               | 1  | $V_S = \pm 18 \text{ V}, V_{CM} = (V+) - 3 \text{ V}$                             | T 4000 : 40500                                       |                             | ±0.5       |              | 1//00                       |
| dV <sub>OS</sub> /dT | Input offset voltage drift   | $V_S = \pm 18 \text{ V}, V_{CM} = (V+) - 1.5 \text{ V}$                           | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ |                             | ±0.8       |              | μV/°C                       |
| PSRR                 | Power-supply rejection ratio   | $T_A = -40$ °C to +125°C  |  |                             | ±0.3       | ±1           | μV/V                        |
| INPUT BI             | AS CURRENT   |   |  | ·                           |            |              |                             |
| I <sub>B</sub>       | Input bias current   |   |  |                             | ±5         | ±20          | pA                          |
| Ios                  | Input offset current   |   |  |                             | ±2         | ±20          | pA                          |
| NOISE                |  |   |  |                             |            |              |                             |
| E <sub>n</sub>       | Input voltage seige  | (V-) - 0.1 V < V <sub>CM</sub> < (V+) - 3 V                                       | f = 0.1 Hz to 10 Hz                                  |                             | 1.4        |              | μV <sub>PP</sub>            |
| ∟ <sub>n</sub>       | Input voltage noise  | $(V+) - 1.5 V < V_{CM} < (V+) + 0.1 V$  | f = 0.1 Hz to 10 Hz                                  |                             | 7          |              | μνρρ                        |
|                      | Input voltage noise density  | $(V-) - 0.1 V < V_{CM} < (V+) - 3 V$  | f = 100 Hz   |                             | 18         |              | nV/√Hz                      |
| •                    |  | (v-) - 0.1 v < v <sub>CM</sub> < (v+) - 3 v                                       | f = 1 kHz  |                             | 15         |              |                             |
| e <sub>n</sub>       |  | $(V+) - 1.5 V < V_{CM} < (V+) + 0.1 V$  | f = 100 Hz   |                             | 53         |              |                             |
|                      |  | (V+) - 1.5 V < V <sub>CM</sub> < (V+) + 0.1 V                                     | f = 1 kHz  |                             | 24         |              |                             |
| i <sub>n</sub>       | Input current noise density  | f = 1 kHz   |  |                             | 1.5        |              | fA/√Hz                      |
| INPUT VO             | DLTAGE   |   |  |                             |            |              |                             |
| V <sub>CM</sub>      | Common-mode voltage range  |   | -  | (V-) - 0.1                  |            | (V+) + 0.1   | V                           |
|                      |  | $V_S = \pm 18 \text{ V},$<br>$(V-) - 0.1 \text{ V} < V_{CM} < (V+) - 3 \text{ V}$ |  | 120                         | 140        |              |                             |
| CMRR                 | Common-mode  | $V_S = \pm 18 \text{ V},$<br>$(V-) < V_{CM} < (V+) - 3 \text{ V}$                 | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | 114                         | 126        |              | dB                          |
|                      | rejection ratio  | V <sub>S</sub> = ±18 V,   |  | 96                          | 120        |              |                             |
|                      |  | $(V+) - 1.5 V < V_{CM} < (V+)$  | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | 86                          | 100        |              |                             |
|                      |  | $(V+) - 3 V < V_{CM} < (V+) - 1.5 V$  |  | See Typical Characteristics |            |              | 1                           |
| INPUT IM             | PEDANCE  |   |  |                             |            |              |                             |
| Z <sub>ID</sub>      | Differential   |   |  | 1                           | 100    1.6 | <del>.</del> | MΩ    pF                    |
| Z <sub>IC</sub>      | Common-mode  |   |  |                             | 1    6.4   |              | 10 <sup>13</sup> Ω   <br>pF |
| OPEN-LO              | OP GAIN  |   |  |                             |            |              |                             |
|                      |  | $V_S = \pm 18 \ V,$   |  | 124                         | 134        |              |                             |
| A <sub>OL</sub>      | Open-loop voltage gain $ \frac{(V-) + 0.6 \text{ V} < V_O < (V+)}{R_L = 2 \text{ k}\Omega} $ | $(V-) + 0.6 V < V_O < (V+) - 0.6 V,$<br>$R_L = 2 k\Omega$                         | $T_A = -40$ °C to +125°C                             | 114                         | 126        |              | dB                          |
| · ·OL                | Sport toop voltage gain  | $V_S = \pm 18 \text{ V},$   |  | 126                         | 140        |              | J.D                         |
|                      |  | $(V-) + 0.3 V < V_O < (V+) - 0.3 V,$<br>$R_L = 10 \text{ k}\Omega$                | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | 120                         | 134        |              |                             |

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# Electrical Characteristics: $V_S = \pm 4 \text{ V to } \pm 18 \text{ V (V}_S = 8 \text{ V to } 36 \text{ V)}$ (continued)

at  $T_A$  = 25°C,  $V_{CM}$  =  $V_{OUT}$  =  $V_S$  / 2, and  $R_L$  = 10 k $\Omega$  connected to  $V_S$  / 2 (unless otherwise noted)

|                 | PARAMETER                         | TEST CONDITIONS                                    |  | MIN TYP               | MAX    | UNIT |  |
|-----------------|-----------------------------------|--|--|-----------------------|--------|------|--|
| FREQUE          | NCY RESPONSE                      |  |  |                       |        |      |  |
| GBW             | Unity gain bandwidth              |  |  | 2.5                   |        | MHz  |  |
| SR              | Slew rate                         | \/ .10\/ C 1 10\/ atan                             | Rising   | 7.5                   |        | 1//  |  |
| SK              | Siew rate                         | $V_S = \pm 18 \text{ V}, G = 1, 10-V \text{ step}$ | Falling  | 5.5                   |        | V/µs |  |
|                 |                                   | To 0.049/ C 20 pF                                  | V <sub>S</sub> = ±18 V, G = 1, 2-V step          | 0.7                   |        |      |  |
|                 | Settling time                     | To 0.01%, C <sub>L</sub> = 20 pF                   | $V_S = \pm 18 \text{ V}, G = 1, 5-\text{V step}$ | 1                     |        |      |  |
| t <sub>s</sub>  | Settling time                     | To 0.0019/ C = 20 pE                               | $V_S = \pm 18 \text{ V}, G = 1, 2-\text{V step}$ | 1.8                   |        | μs   |  |
|                 |                                   | To 0.001%, C <sub>L</sub> = 20 pF                  | V <sub>S</sub> = ±18 V, G = 1, 5-V step          | 3.7                   |        |      |  |
|                 | Overland recovery time            | VC .V  | From overload to negative rail                   | 0.4                   |        |      |  |
| t <sub>OR</sub> | Overload recovery time            | $V_{IN} \times G = V_{S}$                          | From overload to positive rail                   | 1                     |        | μs   |  |
| THD+N           | Total harmonic distortion + noise | $G = 1, f = 1 \text{ kHz}, V_0 = 3.5 V_{RMS}$      |  | 0.0012%               |        |      |  |
|                 | One stalls                        | OPA2196 and OPA4196, at dc                         |  | 150                   |        | dB   |  |
|                 | Crosstalk                         | OPA2196 and OPA4196, f = 100                       | kHz  | 130                   |        | dB   |  |
| OUTPUT          | ī                                 | •  |  |                       | •      |      |  |
|                 |                                   |  | No load  | 5                     | 15     |      |  |
|                 |                                   | Positive rail                                      | $R_L = 10 \text{ k}\Omega$                       | 50                    | 110    | m\/  |  |
| V               | Voltage output swing              |  | $R_L = 2 k\Omega$                                | 200                   | 500    |      |  |
| Vo              | from rail                         |  | No load  | 5                     | 15     | mV   |  |
|                 |                                   | Negative rail                                      | $R_L = 10 \text{ k}\Omega$                       | 50                    | 110    |      |  |
|                 |                                   |  | $R_L = 2 k\Omega$                                | 200                   |        | , ]  |  |
| I <sub>SC</sub> | Short-circuit current             | V <sub>S</sub> = ±18 V                             |  | ±65                   |        | mA   |  |
| C <sub>L</sub>  | Capacitive load drive             |  |  | See Typical Character | istics |      |  |
| Z <sub>O</sub>  | Open-loop output impedance        | f = 1 MHz, I <sub>O</sub> = 0 A, See Figure 1      | 9  | 700                   |        | Ω    |  |
| POWER           | SUPPLY                            |  |  |                       |        |      |  |
| I.              | Quiescent current per             | I <sub>O</sub> = 0 A                               |  | 140                   | 200    | μA   |  |
| IQ              | amplifier                         | 10 - 0 A   | $T_A = -40^{\circ}C \text{ to } +125^{\circ}C$   | 250                   |        | μΛ   |  |
| TEMPER          | RATURE                            |  |  |                       |        |      |  |
|                 | Thermal protection                |  |  | 180                   |        | °C   |  |
|                 | Thermal hysteresis                |  |  | 30                    |        | °C   |  |



## 6.8 Electrical Characteristics: $V_S = \pm 2.25 \text{ V to } \pm 4 \text{ V (}V_S = 4.5 \text{ V to 8 V)}$

at  $T_A$  = +25°C,  $V_{CM}$  =  $V_{OUT}$  =  $V_S$  / 2, and  $R_L$  = 10 k $\Omega$  connected to  $V_S$  / 2 (unless otherwise noted)

|   | PARAMETER                    | TEST CON  | DITIONS  | MIN         | TYP        | MAX        | UNIT                        |
|---|------------------------------|---|--|-------------|------------|------------|-----------------------------|
| OFFSET                                      | VOLTAGE                      |   |  |             |            |            |                             |
| V <sub>OS</sub>                             | Input offset voltage         | $V_S = \pm 2.25V,$<br>$V_{CM} = (V+) - 3 V$   |  | ±25         | ±100       | μV         |                             |
|   |                              | $(V+) - 3.0 \text{ V} < V_{CM} < (V+) - 1.5 \text{ V}$                              |  | See Common- | Mode Vol   | tage Range |                             |
|   |                              | $V_S = \pm 3V,$<br>$V_{CM} = (V+) - 1.5 V$  |  | ±25         | ±100       |            |                             |
| dV <sub>OS</sub> /dT                        | Input offset voltage drift   | $V_S = \pm 2.25 V$ , $V_{CM} = (V+) - 3 V$  | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ |             | ±0.5       |            | μV/°C                       |
| av <sub>os/a1</sub> input onset voltage and |                              | $V_S = \pm 2.25 V$ , $V_{CM} = (V+) - 1.5 V$  | 1 <sub>A</sub> = -40 C to +125 C                     |             |            | μν/ Ο      |                             |
| PSRR  | Power-supply rejection ratio | $T_A = -40$ °C to +125°C, $V_{CM} = V_S / 2$  | 2 – 0.75 V   |             | ±1         |            | μV/V                        |
| INPUT BI                                    | AS CURRENT                   |   |  |             |            |            |                             |
| $I_{B}$                                     | Input bias current           |   |  |             | ±5         | ±20        | pA                          |
| I <sub>OS</sub>                             | Input offset current         |   |  |             | ±2         | ±20        | pА                          |
| NOISE                                       |                              |   |  |             |            |            |                             |
| E <sub>n</sub>                              | Input voltage noise          | $(V-) - 0.1 V < V_{CM} < (V+) - 3 V$  | f = 0.1 Hz to 10 Hz                                  |             | 1.4        |            | $\mu V_{PP}$                |
| -n  | mput voltage noise           | $(V+) - 1.5 V < V_{CM} < (V+) + 0.1 V$  | f = 0.1 Hz to 10 Hz                                  |             | 7          |            | P • PP                      |
|   | Input voltage noise density  | $(V-) - 0.1 V < V_{CM} < (V+) - 3 V$  | f = 100 Hz   | 18          |            |            |                             |
| e <sub>n</sub>                              |                              | · /   | f = 1 kHz  |             | 15         |            | nV/√ <del>Hz</del>          |
| o <sub>n</sub>                              |                              | $(V+) - 1.5 V < V_{CM} < (V+) + 0.1 V$  | f = 100 Hz   |             | 53         |            | 110/ 1112                   |
|   |                              | (V+) = 1.5 V \ V <sub>CM</sub> \ (V+) + 0.1 V                                       | f = 1 kHz  |             | 24         |            |                             |
| i <sub>n</sub>                              | Input current noise density  |   | f = 1 kHz  |             | 1.5        |            | fA/√Hz                      |
| INPUT VO                                    | DLTAGE                       |   |  |             |            |            |                             |
| $V_{CM}$                                    | Common-mode voltage range    |   |  | (V-) - 0.1  |            | (V+) + 0.1 | ٧                           |
|   |                              | $V_S = \pm 2.25 \text{ V},$<br>$(V-) - 0.1 \text{ V} < V_{CM} < (V+) - 3 \text{ V}$ |  | 96          | 110        |            |                             |
| CMRR  | Common-mode rejection        | $V_S = \pm 2.25 \text{ V},$<br>$(V-) < V_{CM} < (V+) - 3 \text{ V}$                 | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | 90          | 104        |            | dB                          |
|   | ratio                        | V <sub>S</sub> = ±2.25 V,   |  | 96          | 120        |            |                             |
|   |                              | $(V+) - 1.5 V < V_{CM} < (V+)$  | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | 84          | 100        |            |                             |
|   |                              | $(V+) - 3 V < V_{CM} < (V+) - 1.5 V$  | See Typical Characteristics                          |             |            |            |                             |
| INPUT IM                                    | PEDANCE                      |   |  |             |            |            |                             |
| $Z_{\text{ID}}$                             | Differential                 |   |  |             | 100    1.6 |            | $MΩ \parallel pF$           |
| $Z_{\text{IC}}$                             | Common-mode                  |   |  |             | 1    6.4   |            | 10 <sup>13</sup> Ω   <br>pF |
| OPEN-LO                                     | OOP GAIN                     |   |  |             |            |            |                             |
| -   |                              | $V_S = \pm 2.25V$ ,   |  | 110         | 120        |            |                             |
| A <sub>OL</sub>                             | Open-loop voltage gain       | $(V-) + 0.6 V < V_O < (V+) - 0.6 V,$<br>$R_L = 2 k\Omega$                           | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | 100         | 114        |            | dB                          |
| , OL  | Sport loop voltage gail      | $V_S = \pm 2.25V$ ,   |  | 110         | 126        |            | GD.                         |
|   |                              | $(V-) + 0.3 \text{ V} < V_O < (V+) - 0.3 \text{ V},$<br>$R_1 = 10 \text{ k}\Omega$  |  | 106         | 120        |            |                             |



## Electrical Characteristics: $V_S = \pm 2.25 \text{ V}$ to $\pm 4 \text{ V}$ ( $V_S = 4.5 \text{ V}$ to 8 V) (continued)

at  $T_A$  = +25°C,  $V_{CM}$  =  $V_{OUT}$  =  $V_S$  / 2, and  $R_L$  = 10 k $\Omega$  connected to  $V_S$  / 2 (unless otherwise noted)

|                 | PARAMETER                  | TEST CO                                       | ONDITIONS  | MIN TY           | P MAX       | UNI  |  |
|-----------------|----------------------------|---|--|------------------|-------------|------|--|
| FREQUE          | ENCY RESPONSE              |   |  |                  |             |      |  |
| GBW             | Unity gain bandwidth       |   |  | 2                | 2           | MH   |  |
| CD.             | 01                         | V .005V 0 4 4 V -+                            | Rising   | 6                | 5           | \//  |  |
| SR              | Slew rate                  | $V_S = \pm 2.25V$ , G = 1, 1-V step           | Falling  | 5                | 5           | V/µ: |  |
|                 | 0                          | V O . V                                       | From overload to negative rail                       | 0                | 4           |      |  |
| t <sub>OR</sub> | Overload recovery time     | $V_{IN} \times G = V_{S}$                     | From overload to positive rail                       |                  | μs          |      |  |
|                 | 0                          | OPA2196 and OPA4196, at dc                    | 15   | 0                | dB          |      |  |
|                 | Crosstalk                  | OPA2196 and OPA4196, f = 100                  | 13   | 0                | dB          |      |  |
| OUTPUT          | T                          |   |  |                  |             | ļ.   |  |
|                 |                            |   | No load  |                  | 5 15        |      |  |
|                 |                            | Positive rail                                 | $R_L = 10 \text{ k}\Omega$                           | 1                | 5 110       | mV   |  |
|                 | Voltage output swing from  |   | $R_L = 2 k\Omega$                                    | 6                | 0 500       |      |  |
| Vo              | rail                       |   | No load  |                  | 5 15        |      |  |
|                 |                            | Negative rail                                 | $R_L = 10 \text{ k}\Omega$                           | 1                | 5 110       |      |  |
|                 |                            |   | $R_L = 2 k\Omega$                                    | 6                | 0 500       |      |  |
| I <sub>sc</sub> | Short-circuit current      | V <sub>S</sub> = ±2.25V                       |  | ±3               | 0           | mA   |  |
| C <sub>L</sub>  | Capacitive load drive      |   |  | See Typical Char | acteristics |      |  |
| Z <sub>O</sub>  | Open-loop output impedance | f = 1 MHz, I <sub>O</sub> = 0 A, see Figure 1 | 9  | 70               | 0           | Ω    |  |
| POWER           | SUPPLY                     |   |  |                  |             |      |  |
|                 | Quiescent current per      |   |  | 14               | 0 200       | μА   |  |
| IQ              | amplifier                  | $I_O = 0 A$                                   | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ |                  | 250         |      |  |
| TEMPER          | RATURE                     |   |  |                  |             |      |  |
|                 | Thermal protection         |   |  | 18               | 0           | °C   |  |
|                 | Thermal hysteresis         |   |  | 3                | 0           | °C   |  |

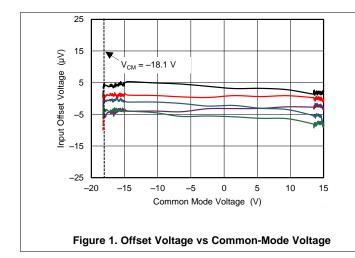


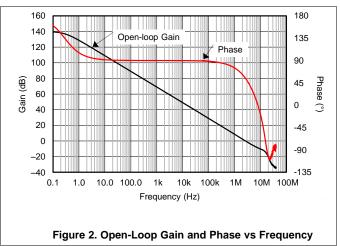
## 6.9 Typical Characteristics

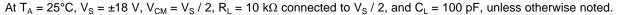
**Table 1. Table of Graphs** 

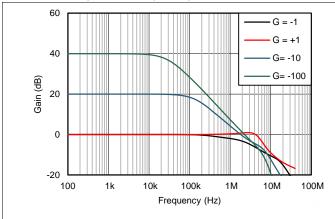
| DESCRIPTION  | FIGURE                                     |  |  |  |  |
|--|--|--|--|--|--|
| Offset Voltage vs Common-Mode Voltage                          | Figure 1                                   |  |  |  |  |
| Open-Loop Gain and Phase vs Frequency                          | Figure 2                                   |  |  |  |  |
| Closed-Loop Gain and Phase vs Frequency                        | Figure 3                                   |  |  |  |  |
| Input Bias Current vs Common-Mode Voltage                      | Figure 4                                   |  |  |  |  |
| Input Bias Current vs Temperature                              | Figure 5                                   |  |  |  |  |
| Output Voltage Swing vs Output Current (maximum supply)        | Figure 6, Figure 7                         |  |  |  |  |
| CMRR and PSRR vs Frequency                                     | Figure 8                                   |  |  |  |  |
| CMRR vs Temperature  | Figure 9                                   |  |  |  |  |
| PSRR vs Temperature  | Figure 10                                  |  |  |  |  |
| 0.1-Hz to 10-Hz Noise  | Figure 11                                  |  |  |  |  |
| Input Voltage Noise Spectral Density vs Frequency              | Figure 12                                  |  |  |  |  |
| THD+N Ratio vs Frequency                                       | Figure 13                                  |  |  |  |  |
| THD+N vs Output Amplitude                                      | Figure 14                                  |  |  |  |  |
| Quiescent Current vs Supply Voltage                            | Figure 15                                  |  |  |  |  |
| Quiescent Current vs Temperature                               | Figure 16                                  |  |  |  |  |
| Open Loop Gain vs Temperature                                  | Figure 17, Figure 18                       |  |  |  |  |
| Open Loop Output Impedance vs Frequency                        | Figure 19                                  |  |  |  |  |
| Small Signal Overshoot vs Capacitive Load (100-mV output step) | Figure 20, Figure 21                       |  |  |  |  |
| No Phase Reversal  | Figure 22                                  |  |  |  |  |
| Overload Recovery  | Figure 23                                  |  |  |  |  |
| Small-Signal Step Response (100 mV)                            | Figure 24, Figure 25                       |  |  |  |  |
| Large-Signal Step Response                                     | Figure 26, Figure 27                       |  |  |  |  |
| Settling Time  | Figure 28, Figure 29, Figure 30, Figure 31 |  |  |  |  |
| Short-Circuit Current vs Temperature                           | Figure 32                                  |  |  |  |  |
| Maximum Output Voltage vs Frequency                            | Figure 33                                  |  |  |  |  |
| Propagation Delay Rising Edge                                  | Figure 34                                  |  |  |  |  |
| Propagation Delay Falling Edge                                 | Figure 35                                  |  |  |  |  |

At  $T_A$  = 25°C,  $V_S$  = ±18 V,  $V_{CM}$  =  $V_S$  / 2,  $R_L$  = 10 k $\Omega$  connected to  $V_S$  / 2, and  $C_L$  = 100 pF, unless otherwise noted.









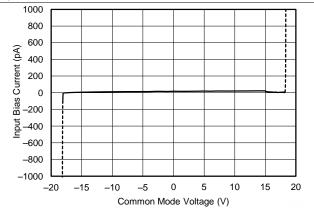
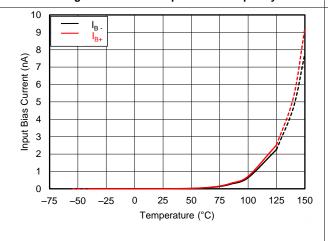


Figure 3. Closed-Loop Gain vs Frequency

Figure 4. Input Bias Current vs Common-Mode Voltage



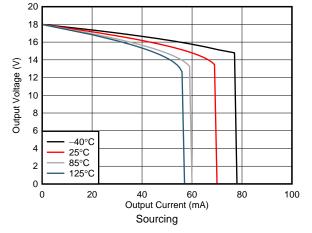
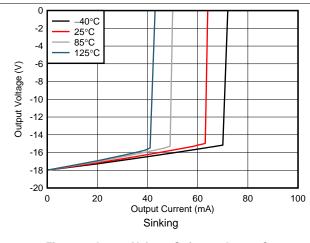


Figure 5. Input Bias Current vs Temperature

Figure 6. Output Voltage Swing vs Output Current



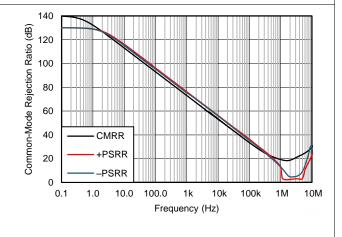
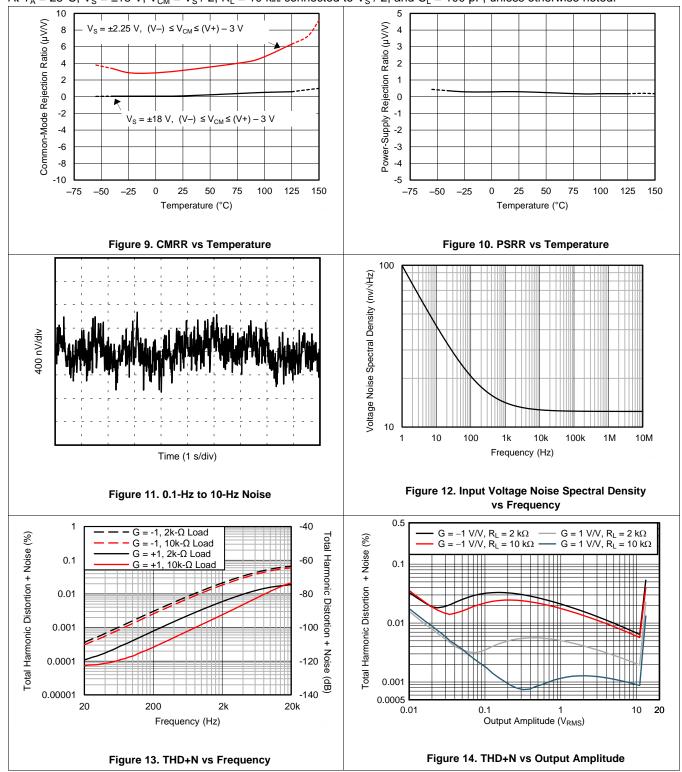
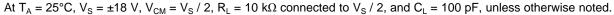


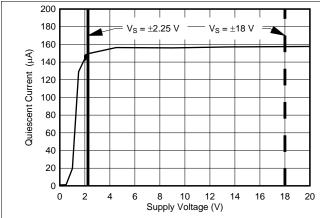
Figure 7. Output Voltage Swing vs Output Current

Figure 8. CMRR and PSRR vs Frequency

At  $T_A = 25^{\circ}C$ ,  $V_S = \pm 18$  V,  $V_{CM} = V_S / 2$ ,  $R_L = 10$  k $\Omega$  connected to  $V_S / 2$ , and  $C_L = 100$  pF, unless otherwise noted.







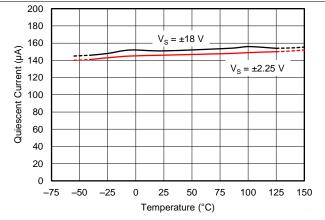
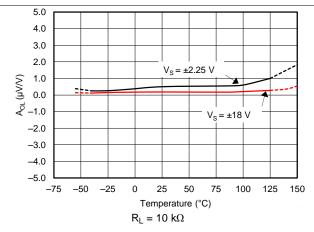


Figure 15. Quiescent Current vs Supply Voltage

Figure 16. Quiescent Current vs Temperature



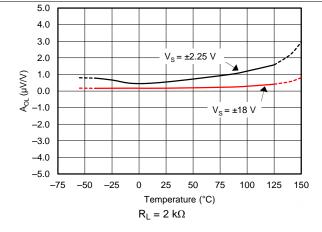
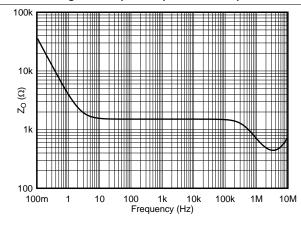


Figure 17. Open-Loop Gain vs Temperature

Figure 18. Open-Loop Gain vs Temperature



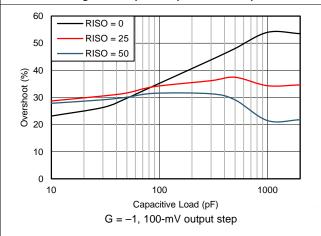


Figure 19. Open-Loop Output Impedance vs Frequency

Figure 20. Small-Signal Overshoot vs Capacitive Load (100-mV Output Step)

At  $T_A = 25^{\circ}C$ ,  $V_S = \pm 18$  V,  $V_{CM} = V_S / 2$ ,  $R_L = 10$  k $\Omega$  connected to  $V_S / 2$ , and  $C_L = 100$  pF, unless otherwise noted.

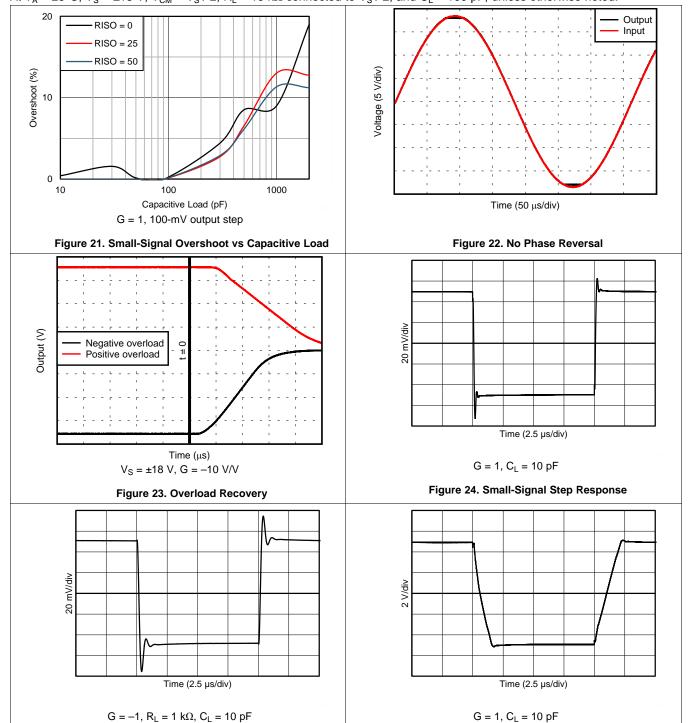
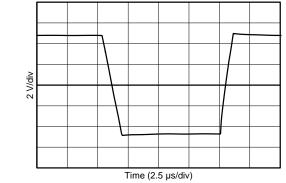


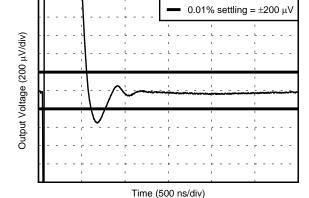
Figure 25. Small-Signal Step Response

Figure 26. Large-Signal Step Response

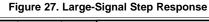


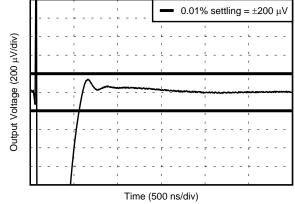


 $G=-1,~R_L=1~k\Omega,~C_L=10~pF$ 

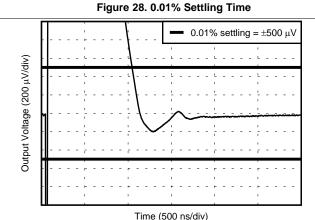


Gain = 1, 2-V step, rising, step applied at  $t = 0 \mu s$  on all four plots

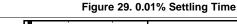




Gain = 1, 2-V step, falling, step applied at  $t = 0 \mu s$ 



Gain = 1, 5-V step, rising, step applied at  $t = 0 \mu s$ 



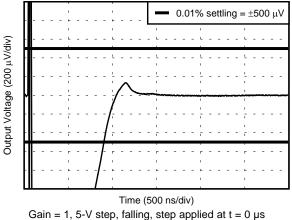


Figure 31. 0.01% Settling Time

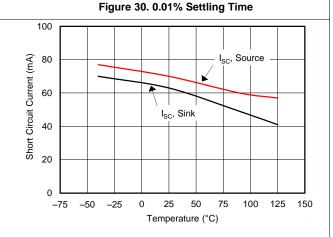
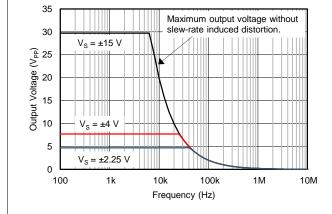


Figure 32. Short-Circuit Current vs Temperature







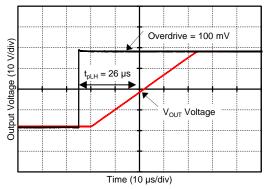


Figure 33. Maximum Output Voltage vs Frequency

Figure 34. Propagation Delay Rising Edge

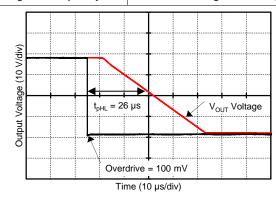


Figure 35. Propagation Delay Falling Edge



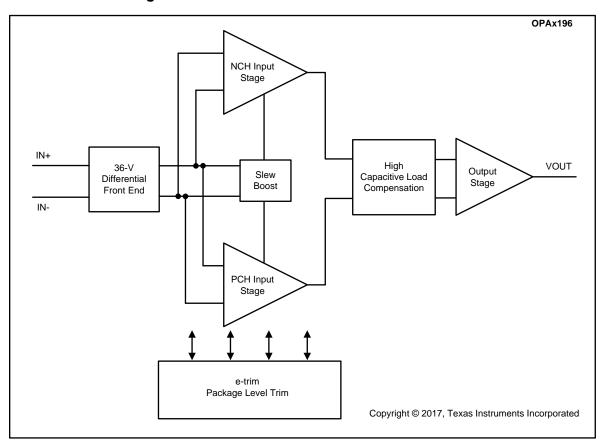
## 7 Detailed Description

#### 7.1 Overview

The OPAx196 family of operational amplifiers use *e-trim*, a method of package-level trim for offset and offset temperature drift implemented during the final steps of manufacturing after the plastic molding process. This method minimizes the influence of inherent input transistor mismatch, as well as errors induced during package molding. The trim communication occurs on the output pin of the standard pinout, and after the trim points are set, further communication to the trim structure is permanently disabled. The *Functional Block Diagram* shows the simplified diagram of the OPA196 with e-trim.

Unlike previous e-trim op amps, the OPAx196 uses a patented two-temperature trim architecture to achieve a very low offset voltage and low voltage offset drift over the full specified temperature range. This level of precision performance at wide supply voltages makes these amplifiers useful for high-impedance industrial sensors, filters, and high-voltage data acquisition.

## 7.2 Functional Block Diagram





## 7.3 Feature Description

## 7.3.1 Input Protection Circuitry

The OPAx196 uses a unique input architecture to eliminate the need for input protection diodes but still provides robust input protection under transient conditions. Conventional input diode protection schemes shown in Figure 36 can be activated by fast transient step responses and can introduce signal distortion and settling time delays because of alternate current paths, as shown in Figure 37. For low-gain circuits, these fast-ramping input signals forward-bias back-to-back diodes that cause an increase in input current, resulting in extended settling time.

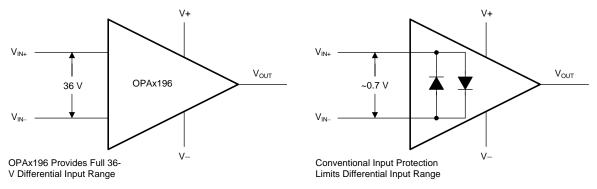


Figure 36. OPA196 Input Protection Does Not Limit Differential Input Capability

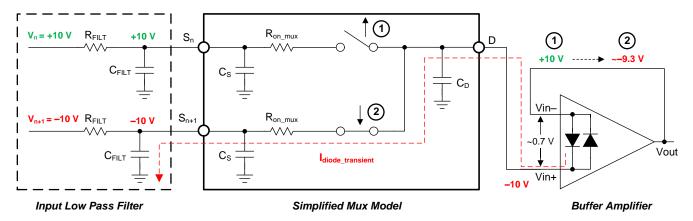


Figure 37. Back-to-Back Diodes Create Settling Issues

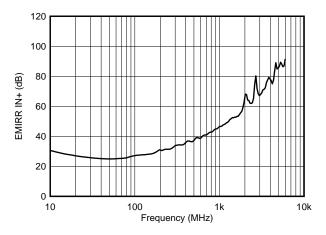
The OPAx196 family of operational amplifiers provides a true high-impedance differential input capability for high-voltage applications. This patented input protection architecture does not introduce additional signal distortion or delayed settling time, making the device an optimal op amp for multichannel, high-switched, input applications. The OPA196 can tolerate a maximum differential swing (voltage between inverting and noninverting pins of the op amp) of up to 36 V, making the device suitable for use as a comparator or in applications with fast-ramping input signals such as multiplexed data-acquisition systems (see Figure 49).

# TEXAS INSTRUMENTS

## **Feature Description (continued)**

### 7.3.2 EMI Rejection

The OPAx196 uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPAx196 benefits from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. Figure 38 shows the results of this testing on the OPAx196. Table 2 shows the EMIRR IN+ values for the OPAx196 at particular frequencies commonly encountered in real-world applications. Applications listed in Table 2 may be centered on or operated near the particular frequency shown. Detailed information can also be found in the application report *EMI Rejection Ratio of Operational Amplifiers*, available for download from www.ti.com.



 $P_{RF} = -10 \text{ dBm}, V_S = \pm 15 \text{ V}, V_{CM} = 0 \text{ V}$ 

Figure 38. EMIRR Testing

Table 2. OPA196 EMIRR IN+ For Frequencies of Interest

| FREQUENCY | APPLICATION OR ALLOCATION  | EMIRR IN+ |
|-----------|--|-----------|
| 400 MHz   | Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications   | 36 dB     |
| 900 MHz   | Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6 GHz), GSM, aeronautical mobile, UHF applications                        | 45 dB     |
| 1.8 GHz   | GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz)  | 57 dB     |
| 2.4 GHz   | 802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz) | 62 dB     |
| 3.6 GHz   | Radiolocation, aero communication and navigation, satellite, mobile, S-band  | 76 dB     |
| 5.0 GHz   | 802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz)  | 86 dB     |

## 7.3.3 Phase Reversal Protection

The OPAx196 family has internal phase-reversal protection. Many op amps exhibit phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The OPAx196 is a rail-to-rail input op amp, and therefore the common-mode range can extend up to the rails. Input signals beyond the rails do not cause phase reversal; instead, the output limits into the appropriate rail. This performance is shown in Figure 39.

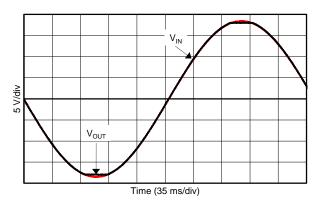


Figure 39. No Phase Reversal

#### 7.3.4 Thermal Protection

The internal power dissipation of any amplifier causes the internal (junction) temperature to rise. This phenomenon is called *self heating*. The OPAx196 has a thermal protection feature that prevents damage from self heating.

This thermal protection works by monitoring the temperature of the output stage and turning off the op amp output drive for temperatures above approximately 180°C. Thermal protection forces the output to a high-impedance state. The OPAx196 is also designed with approximately 30°C of thermal hysteresis. Thermal hysteresis prevents the output stage from cycling in and out of the high-impedance state. The OPAx196 returns to normal operation when the output stage temperature falls below approximately 150°C.

The absolute maximum junction temperature of the OPAx196 is 150°C. Exceeding the limits shown in the *Absolute Maximum Ratings* table may cause damage to the device. Thermal protection triggers at 180°C because of unit-to-unit variance, but does not interfere with device operation up to the absolute maximum ratings. This thermal protection is not designed to prevent this device from exceeding absolute maximum ratings, but rather from excessive thermal overload.

## 7.3.5 Capacitive Load and Stability

The OPAx196 features a patented output stage capable of driving large capacitive loads, and in a unity-gain configuration, directly drives up to 1 nF of pure capacitive load. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads; see Figure 40. The particular op amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether an amplifier will be stable in operation.

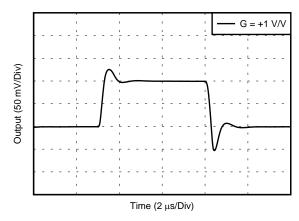


Figure 40. Transient Response with a Purely Capacitive Load of 1 nF

Like many low-power amplifiers, some ringing can occur even with capacitive loads less than 100 pF. In unity-gain configurations with no or very light dc loads, place an RC snubber circuit at the OPAx196 output to reduce any possibility of ringing in lightly-loaded applications. Figure 41 illustrates the recommended RC snubber circuit.

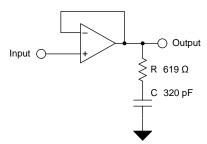


Figure 41. RC Snubber Circuit for Lightly-Loaded Applications in Unity Gain

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For additional drive capability in unity-gain configurations, improve capacitive load drive by inserting a small,  $10-\Omega$  to  $20-\Omega$  resistor ( $R_{ISO}$ ) in series with the output, as shown in Figure 42. This resistor significantly reduces ringing while maintaining dc performance for purely capacitive loads. However, if there is a resistive load in parallel with the capacitive load, a voltage divider is created, introducing a gain error at the output and slightly reducing the output swing. The error introduced is proportional to the ratio  $R_{ISO}$  /  $R_L$  and is generally negligible at low output levels. A high capacitive load drive makes the OPA196 well suited for applications such as reference buffers, MOSFET gate drives, and cable-shield drives. The circuit shown in Figure 42 uses  $R_{ISO}$  to stabilize the output of an op amp.  $R_{ISO}$  modifies the open-loop gain of the system for increased phase margin. Results using the OPA196 are summarized in Table 3. For additional information on techniques to optimize and design using this circuit, TI Precision Design TIDU032 details complete design goals, simulation, and test results.

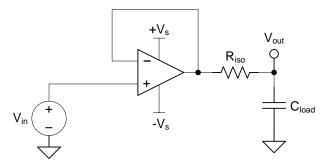


Figure 42. Extending Capacitive Load Drive With the OPA196

Table 3. OPA196 Capacitive Load Drive Solution Using Isolation Resistor Comparison of Calculated and Measured Results

| PARAMETER                 |                | VALUE |     |      |     |      |      |     |     |  |  |  |
|---------------------------|----------------|-------|-----|------|-----|------|------|-----|-----|--|--|--|
| Capacitive Load           | 100 pF 1000 pF |       | 0.0 | 1 μF | 0.1 | μF   | 1 μF |     |     |  |  |  |
| Phase Margin              | 45°            | 45°   | 60° | 45°  | 60° | 45°  | 60°  | 45° | 60° |  |  |  |
| R <sub>ISO</sub> (Ω)      | 280            | 113   | 432 | 68   | 210 | 17.8 | 53.6 | 3.6 | 10  |  |  |  |
| Measured<br>Overshoot (%) | 23             | 23    | 8   | 23   | 8   | 23   | 8    | 23  | 8   |  |  |  |



For step-by-step design procedure, circuit schematics, bill of materials, printed circuit board (PCB) files, simulation results, and test results, refer to TI Precision Design TIDU032, Capacitive Load Drive Solution using an Isolation Resistor.

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#### 7.3.6 Common-Mode Voltage Range

The OPAx196 is a 36-V, true rail-to-rail input operational amplifier with an input common-mode range that extends 100 mV beyond either supply rail. This wide range is achieved with paralleled complementary N-channel and P-channel differential input pairs, as shown in Figure 43. The N-channel pair is active for input voltages close to the positive rail, typically (V+) - 3 V to 100 mV above the positive supply. The P-channel pair is active for inputs from 100 mV below the negative supply to approximately (V+) - 1.5 V. There is a small transition region, typically (V+) - 3 V to (V+) - 1.5 V in which both input pairs are active. This transition region varies modestly with process variation. Within this region PSRR, CMRR, offset voltage, offset drift, noise, and THD performance are degraded compared to operation outside this region.

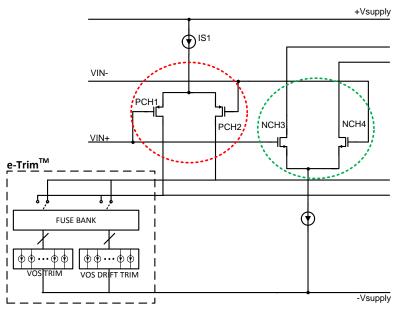


Figure 43. Rail-to-Rail Input Stage

To achieve the best performance for two-stage rail-to-rail input amplifiers, avoid the transition region when possible. The OPAx196 uses a precision trim for both the N-channel and P-channel regions. This technique enables significantly lower levels of offset than previous-generation devices, causing variance in the transition region of the input stages to appear exaggerated relative to offset over the full common-mode range, as shown in Figure 44.

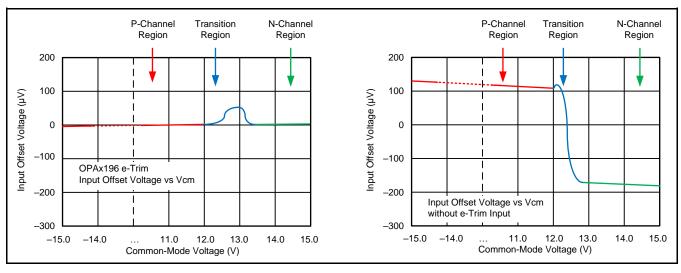


Figure 44. Common-Mode Transition vs Standard Rail-to-Rail Amplifiers

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#### 7.3.7 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress (EOS). These questions tend to focus on the device inputs, but may involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and its relevance to an electrical overstress event is helpful. See Figure 45 for an illustration of the ESD circuits contained in the OPAx196 (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device or the power-supply ESD cell, internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

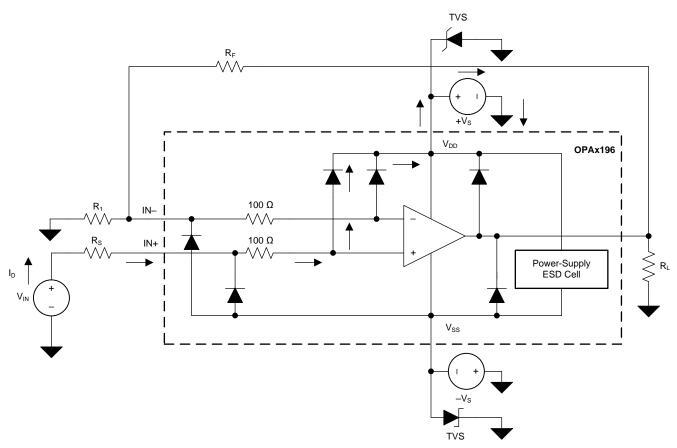


Figure 45. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application





An ESD event is very high voltage for a very short duration (for example, 1 kV for 100 ns); whereas, an EOS event is lower voltage for a longer duration (for example, 50 V for 100 ms). The ESD diodes are designed for out-of-circuit ESD protection (that is, during assembly, test, and storage of the device before being soldered to the PCB). During an ESD event, the ESD signal is passed through the ESD steering diodes to an absorption circuit labeled ESD power-supply circuit. The ESD absorption circuit clamps the supplies to a safe level.

Although this behavior is necessary for out-of-circuit protection, excessive current and damage is caused if activated in-circuit. A transient voltage suppressor (TVS) can be used to prevent against damage caused by turning on the ESD absorption circuit during an in-circuit ESD event. Using the appropriate current limiting resistors and TVS diodes allows for the use of device ESD diodes to protect against EOS events.

#### 7.3.8 Overload Recovery

Overload recovery is defined as the time required for the op amp output to recover from a saturated state to a linear state. The output devices of the op amp enter a saturation region when the output voltage exceeds the rated operating voltage, either due to the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices require time to return back to the linear state. After the charge carriers return back to the linear state, the device begins to slew at the specified slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time.

#### 7.4 Device Functional Modes

The OPAx196 has a single functional mode and is operational when the power-supply voltage is greater than 4.5 V (±2.25 V). The maximum power supply voltage for the OPAx196 is 36 V (±18 V).



## 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

The OPAx196 family offers outstanding dc precision and ac performance. These devices operate up to 36-V supply rails and offer true rail-to-rail input/output, ultralow offset voltage and offset voltage drift, as well as 2-MHz bandwidth and high capacitive load drive. These features make the OPAx196 a robust, high-performance operational amplifier for high-voltage industrial applications.

## 8.2 Typical Applications

#### 8.2.1 Low-side Current Measurement

Figure 46 shows the OPA196 configured in a low-side current sensing application. For a full analysis of the circuit shown in Figure 46 including theory, calculations, simulations, and measured data see the 0-1A, single-supply, low-side, current sensing solution, see TIPD129.

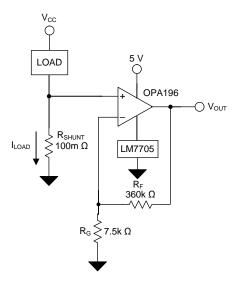


Figure 46. OPA196 in a Low-Side, Current-Sensing Application

#### 8.2.1.1 Design Requirements

The design requirements for this design are:

Load current: 0 A to 1 AOutput voltage: 4.9 V

Maximum shunt voltage: 100 mV

## **Typical Applications (continued)**

### 8.2.1.2 Detailed Design Procedure

The transfer function of the circuit in Figure 46 is given in Equation 1:

$$V_{OUT} = I_{LOAD} \times R_{SHUNT} \times Gain$$
 (1)

The load current ( $I_{LOAD}$ ) produces a voltage drop across the shunt resistor ( $R_{SHUNT}$ ). The load current is set from 0 A to 1 A. To keep the shunt voltage below 100 mV at maximum load current, the largest shunt resistor is defined using Equation 2.

$$R_{SHUNT} = \frac{V_{SHUNT\_MAX}}{I_{LOAD\_MAX}} = \frac{100mV}{1A} = 100m\Omega$$
 (2)

Using Equation 2,  $R_{SHUNT}$  is calculated to be 100 m $\Omega$ . The voltage drop produced by  $I_{LOAD}$  and  $R_{SHUNT}$  is amplified by the OPA196 to produce an output voltage of 0 V to 4.9 V. The gain needed by the OPA196 to produce the necessary output voltage is calculated using Equation 3:

$$Gain = \frac{\left(V_{OUT\_MAX} - V_{OUT\_MIN}\right)}{\left(V_{IN\_MAX} - V_{IN\_MIN}\right)}$$
(3)

Using Equation 3, the required gain is calculated to be 49 V/V, which is set with resistors  $R_F$  and  $R_G$ . Equation 4 is used to size the resistors,  $R_F$  and  $R_G$ , to set the gain of the OPA196 to 49 V/V.

$$Gain = 1 + \frac{(R_F)}{(R_G)}$$
(4)

Choosing  $R_F$  as 360 k $\Omega$ ,  $R_G$  is calculated to be 7.5 k $\Omega$ .  $R_F$  and  $R_G$  were chosen as 360 k $\Omega$  and 7.5 k $\Omega$  because they are standard value resistors that create a 49:1 ratio. Other resistors that create a 49:1 ratio can also be used. Figure 2 shows the measured transfer function of the circuit shown in Figure 46.

## 8.2.1.3 Application Curves

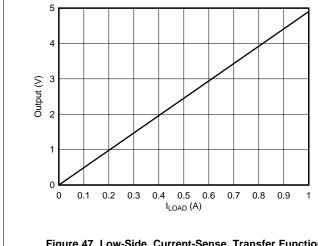


Figure 47. Low-Side, Current-Sense, Transfer Function

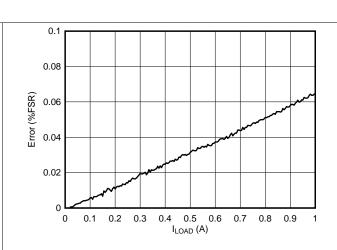


Figure 48. Low-Side, Current-Sense, Full-Scale Error

### Typical Applications (continued)

### 8.2.2 16-Bit Precision Multiplexed Data-Acquisition System

Figure 49 shows a 16-bit, differential, 4-channel, multiplexed, data-acquisition system. This example is typical in industrial applications that require low distortion and a high-voltage differential input. The circuit uses the ADS8864, a 16-bit, 400-kSPS successive-approximation-resistor (SAR), analog-to-digital converter (ADC), along with a precision, high-voltage, signal-conditioning front-end, and a 4-channel differential multiplexer (mux). This application example shows the process for optimizing the precision, high-voltage, front-end drive circuit using the OPA196 and OPA140 to achieve excellent dynamic performance and linearity with the ADS8864. The full TI Precision Design can be found in TIDU181.

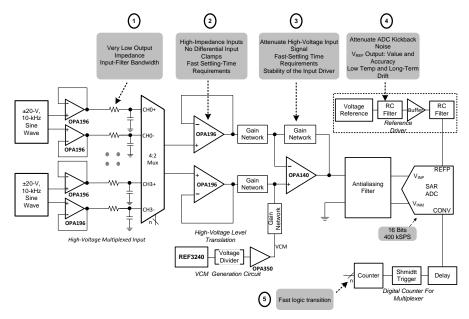


Figure 49. OPA196 in 16-Bit, 400-kSPS, 4-Channel, Multiplexed Data Acquisition System for High-Voltage **Inputs With Lowest Distortion** 

### 8.2.2.1 Design Requirements

The primary objective is to design a ±20-V, differential, 4-channel, multiplexed, data acquisition system with lowest distortion using the 16-bit ADS8864 at a throughput of 400 kSPS for a 10-kHz, full-scale, pure sine-wave input. The design requirements for this block design are:

- System supply voltage: ±15 V ADC supply voltage: 3.3 V
- ADC sampling rate: 400 kSPS
- ADC reference voltage (REFP): 4.096 V
- System input signal: A high-voltage differential input signal with a peak amplitude of 10 V and frequency (f<sub>IN</sub>) of 10 kHz are applied to each differential input of the mux.

#### 8.2.2.2 Detailed Design Procedure

The purpose of this application example is to design an optimal, high-voltage, multiplexed, data-acquisition system for highest system linearity and fast settling. The overall system block diagram is shown in Figure 49. The circuit is a multichannel, data-acquisition, signal chain consisting of an input low-pass filter, multiplexer (mux), mux output buffer, attenuating SAR ADC driver, digital counter for the mux, and the reference driver. The architecture allows fast sampling of multiple channels using a single ADC, providing a low-cost solution. The two primary design considerations to maximize the performance of a precision, multiplexed, data-acquisition system are the mux input analog front-end and the high-voltage, level translation, SAR ADC driver design. However, carefully design each analog circuit block based on the ADC performance specifications in order to achieve the fastest settling at 16-bit resolution and lowest distortion system. Figure 49 includes the most important specifications for each individual analog block.



## **Typical Applications (continued)**

This design systematically approaches each analog circuit block to achieve a 16-bit settling for a full-scale input stage voltage and linearity for a 10-kHz sinusoidal input signal at each input channel. The first step in the design is to understand the requirement for an extremely-low-impedance input-filter design for the mux. This understanding helps in the decision of an appropriate input filter and selection of a mux to meet the system settling requirements. The next important step is the design of the attenuating analog front-end (AFE) used to level translate the high-voltage input signal to a low-voltage ADC input while maintaining the amplifier stability. Then, the next step is to design a digital interface to switch the mux input channels with minimum delay. The final design challenge is to design a high-precision, reference-driver circuit that provides the required REFP reference voltage with low offset, drift, and noise contributions.



For step-by-step design procedure, circuit schematics, bill of materials, PCB files, simulation results, and test results, refer to TI Precision Design TIDU181, 16-bit, 400-kSPS, 4-Channel, Multiplexed Data Acquisition System for High Voltage Inputs with Lowest Distortion.

## 8.2.3 Slew Rate Limit for Input Protection

In control systems for valves or motors, abrupt changes in voltages or currents can cause mechanical damages. By controlling the slew rate of the command voltages into the drive circuits, the load voltages ramps up and down at a safe rate. For symmetrical slew-rate applications (positive slew rate equals negative slew rate), one additional op amp provides slew-rate control for a given analog gain stage. The unique input protection and high output current and slew rate of the OPAx196 make the device an optimal amplifier to achieve slew rate control for both dual- and single-supply systems. Figure 50 shows the OPA196 in a slew-rate limit design.

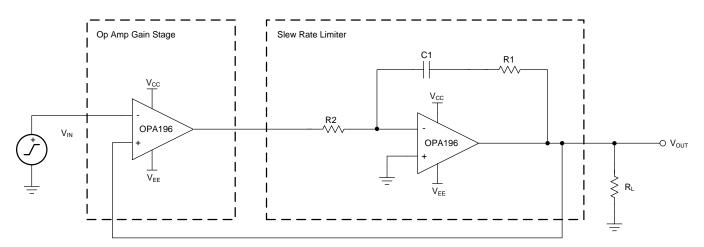


Figure 50. Slew Rate Limiter Uses One Op Amp



For step-by-step design procedure, circuit schematics, bill of materials, PCB files, simulation results, and test results, refer to TI Precision Design TIDU026, *Slew Rate Limiter Uses One Op Amp*.

## 9 Power-Supply Recommendations

The OPAx196 is specified for operation from 4.5 V to 36 V (±2.25 V to ±18 V); many specifications apply from -40°C to +125°C. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

#### CAUTION

Supply voltages larger than 40 V can permanently damage the device; see the Absolute Maximum Ratings.

Place 0.1-μF bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or highimpedance power supplies. For more detailed information on bypass capacitor placement, refer to the Layout section.

## 10 Layout

## 10.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close as possible to the device. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
  - Noise can propagate into analog circuitry through the power pins of the circuit as a whole and op amp itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
- Make sure to physically separate digital and analog grounds paying attention to the flow of the ground current. Separate grounding for analog and digital portions of circuitry is one of the simplest and mosteffective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup.
- In order to reduce parasitic coupling, run the input traces as far away as possible from the supply or output traces. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As shown in Figure 52, keeping RF and RG close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Clean the PCB following board assembly for best performance.
- Any precision integrated circuit may experience performance shifts due to moisture ingress into the plastic package. After any aqueous PCB cleaning process, bake the PCB assembly to remove moisture introduced into the device packaging during the cleaning process. A low-temperature, post-cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

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## 10.2 Layout Example

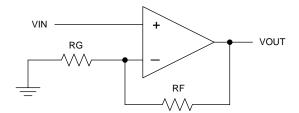


Figure 51. Schematic Representation

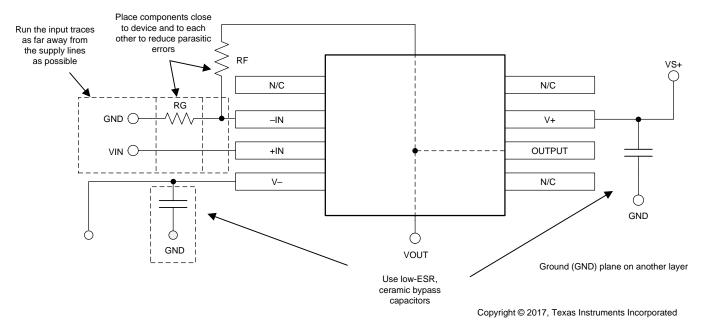


Figure 52. Operational Amplifier Board Layout for Non-inverting Configuration

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## 11 Device and Documentation Support

## 11.1 Device Support

### 11.1.1 Development Support

### 11.1.1.1 TINA-TI™ (Free Software Download)

TINA™ is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional dc, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a free download from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic guick-start tool.

#### NOTE

These files require that either the TINA software (from DesignSoft™) or TINA-TI software be installed. Download the free TINA-TI software from the TINA-TI folder at http://www.ti.com/tool/tina-ti.

#### 11.1.1.2 TI Precision Designs

TI Precision Designs, available online at http://www.ti.com/ww/en/analog/precision-designs/, are analog solutions created by TI's precision analog applications experts and offer the theory of operation, component selection, simulation, complete PCB schematic and layout, bill of materials, and measured performance of many useful circuits.

## 11.2 Documentation Support

#### 11.2.1 Related Documentation

- EMI Rejection Ratio of Operational Amplifiers
- 0-1A, Single-Supply, Low-Side, Current Sensing Solution
- Op Amps for Everyone

#### 11.3 Related Links

Table 4 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

Table 4. Related Links

| PARTS   | PRODUCT FOLDER | ORDER NOW  | TECHNICAL DOCUMENTS | TOOLS & SOFTWARE | SUPPORT & COMMUNITY |
|---------|----------------|------------|---------------------|------------------|---------------------|
| OPA196  | Click here     | Click here | Click here          | Click here       | Click here          |
| OPA2196 | Click here     | Click here | Click here          | Click here       | Click here          |
| OPA4196 | Click here     | Click here | Click here          | Click here       | Click here          |

## 11.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

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## 11.5 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.6 Trademarks

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### 11.7 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.8 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

10-Nov-2025

## **PACKAGING INFORMATION**

| Orderable part number | Status (1) | Material type | Package   Pins   | Package qty   Carrier | <b>RoHS</b> (3) | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking (6) |
|-----------------------|------------|---------------|------------------|-----------------------|-----------------|-------------------------------|----------------------------|--------------|------------------|
| OPA196ID              | Active     | Production    | SOIC (D)   8     | 75   TUBE             | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OPA196           |
| OPA196ID.B            | Active     | Production    | SOIC (D)   8     | 75   TUBE             | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OPA196           |
| OPA196IDBVR           | Active     | Production    | SOT-23 (DBV)   5 | 3000   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDBVR.B         | Active     | Production    | SOT-23 (DBV)   5 | 3000   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDBVRG4         | Active     | Production    | SOT-23 (DBV)   5 | 3000   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDBVRG4.B       | Active     | Production    | SOT-23 (DBV)   5 | 3000   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDBVT           | Active     | Production    | SOT-23 (DBV)   5 | 250   SMALL T&R       | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDBVT.B         | Active     | Production    | SOT-23 (DBV)   5 | 250   SMALL T&R       | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDGKR           | Active     | Production    | VSSOP (DGK)   8  | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDGKR.B         | Active     | Production    | VSSOP (DGK)   8  | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDGKT           | Active     | Production    | VSSOP (DGK)   8  | 250   SMALL T&R       | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDGKT.B         | Active     | Production    | VSSOP (DGK)   8  | 250   SMALL T&R       | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | O196             |
| OPA196IDR             | Active     | Production    | SOIC (D)   8     | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OPA196           |
| OPA196IDR.B           | Active     | Production    | SOIC (D)   8     | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OPA196           |
| OPA196IDRG4           | Active     | Production    | SOIC (D)   8     | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OPA196           |
| OPA196IDRG4.B         | Active     | Production    | SOIC (D)   8     | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OPA196           |
| OPA2196ID             | Active     | Production    | SOIC (D)   8     | 75   TUBE             | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OP2196           |
| OPA2196ID.B           | Active     | Production    | SOIC (D)   8     | 75   TUBE             | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OP2196           |
| OPA2196IDG4           | Active     | Production    | SOIC (D)   8     | 75   TUBE             | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OP2196           |
| OPA2196IDG4.B         | Active     | Production    | SOIC (D)   8     | 75   TUBE             | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OP2196           |
| OPA2196IDGKR          | Active     | Production    | VSSOP (DGK)   8  | 2500   LARGE T&R      | Yes             | Call TI   Nipdau              | Level-2-260C-1 YEAR        | -40 to 125   | 2196             |
| OPA2196IDGKR.B        | Active     | Production    | VSSOP (DGK)   8  | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 2196             |
| OPA2196IDGKRG4        | Active     | Production    | VSSOP (DGK)   8  | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 2196             |
| OPA2196IDGKRG4.B      | Active     | Production    | VSSOP (DGK)   8  | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 2196             |
| OPA2196IDGKT          | Active     | Production    | VSSOP (DGK)   8  | 250   SMALL T&R       | Yes             | Call TI   Nipdau              | Level-2-260C-1 YEAR        | -40 to 125   | 2196             |
| OPA2196IDGKT.B        | Active     | Production    | VSSOP (DGK)   8  | 250   SMALL T&R       | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 2196             |
| OPA2196IDR            | Active     | Production    | SOIC (D)   8     | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OP2196           |
| OPA2196IDR.B          | Active     | Production    | SOIC (D)   8     | 2500   LARGE T&R      | Yes             | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | OP2196           |
| OPA4196ID             | Active     | Production    | SOIC (D)   14    | 50   TUBE             | Yes             | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | OPA4196          |



10-Nov-2025

| Orderable part number | Status | Material type | Package   Pins | Package qty   Carrier | RoHS | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking (6) |
|-----------------------|--------|---------------|----------------|-----------------------|------|-------------------------------|----------------------------|--------------|------------------|
|                       | (.,    | (=)           |                |                       | (8)  | (4)                           | (5)                        |              | (0)              |
| OPA4196ID.B           | Active | Production    | SOIC (D)   14  | 50   TUBE             | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | OPA4196          |
| OPA4196IDR            | Active | Production    | SOIC (D)   14  | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | OPA4196          |
| OPA4196IDR.B          | Active | Production    | SOIC (D)   14  | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | OPA4196          |
| OPA4196IDRG4          | Active | Production    | SOIC (D)   14  | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | OPA4196          |
| OPA4196IDRG4.B        | Active | Production    | SOIC (D)   14  | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | OPA4196          |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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## TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device         | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| OPA196IDBVR    | SOT-23          | DBV                | 5  | 3000 | 180.0                    | 8.4                      | 3.23       | 3.17       | 1.37       | 4.0        | 8.0       | Q3               |
| OPA196IDBVRG4  | SOT-23          | DBV                | 5  | 3000 | 180.0                    | 8.4                      | 3.23       | 3.17       | 1.37       | 4.0        | 8.0       | Q3               |
| OPA196IDBVT    | SOT-23          | DBV                | 5  | 250  | 180.0                    | 8.4                      | 3.23       | 3.17       | 1.37       | 4.0        | 8.0       | Q3               |
| OPA196IDGKR    | VSSOP           | DGK                | 8  | 2500 | 330.0                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA196IDGKT    | VSSOP           | DGK                | 8  | 250  | 177.8                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA196IDR      | SOIC            | D                  | 8  | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| OPA196IDRG4    | SOIC            | D                  | 8  | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| OPA2196IDGKR   | VSSOP           | DGK                | 8  | 2500 | 330.0                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA2196IDGKRG4 | VSSOP           | DGK                | 8  | 2500 | 330.0                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA2196IDGKT   | VSSOP           | DGK                | 8  | 250  | 180.0                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA2196IDR     | SOIC            | D                  | 8  | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| OPA4196IDR     | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| OPA4196IDRG4   | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |



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\*All dimensions are nominal

| Device         | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| OPA196IDBVR    | SOT-23       | DBV             | 5    | 3000 | 213.0       | 191.0      | 35.0        |
| OPA196IDBVRG4  | SOT-23       | DBV             | 5    | 3000 | 213.0       | 191.0      | 35.0        |
| OPA196IDBVT    | SOT-23       | DBV             | 5    | 250  | 213.0       | 191.0      | 35.0        |
| OPA196IDGKR    | VSSOP        | DGK             | 8    | 2500 | 346.0       | 346.0      | 29.0        |
| OPA196IDGKT    | VSSOP        | DGK             | 8    | 250  | 213.0       | 191.0      | 35.0        |
| OPA196IDR      | SOIC         | D               | 8    | 2500 | 353.0       | 353.0      | 32.0        |
| OPA196IDRG4    | SOIC         | D               | 8    | 2500 | 353.0       | 353.0      | 32.0        |
| OPA2196IDGKR   | VSSOP        | DGK             | 8    | 2500 | 353.0       | 353.0      | 32.0        |
| OPA2196IDGKRG4 | VSSOP        | DGK             | 8    | 2500 | 353.0       | 353.0      | 32.0        |
| OPA2196IDGKT   | VSSOP        | DGK             | 8    | 250  | 213.0       | 191.0      | 35.0        |
| OPA2196IDR     | SOIC         | D               | 8    | 2500 | 353.0       | 353.0      | 32.0        |
| OPA4196IDR     | SOIC         | D               | 14   | 2500 | 353.0       | 353.0      | 32.0        |
| OPA4196IDRG4   | SOIC         | D               | 14   | 2500 | 353.0       | 353.0      | 32.0        |

# **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



\*All dimensions are nominal

| Device        | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|---------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| OPA196ID      | D            | SOIC         | 8    | 75  | 506.6  | 8      | 3940   | 4.32   |
| OPA196ID.B    | D            | SOIC         | 8    | 75  | 506.6  | 8      | 3940   | 4.32   |
| OPA2196ID     | D            | SOIC         | 8    | 75  | 506.6  | 8      | 3940   | 4.32   |
| OPA2196ID.B   | D            | SOIC         | 8    | 75  | 506.6  | 8      | 3940   | 4.32   |
| OPA2196IDG4   | D            | SOIC         | 8    | 75  | 506.6  | 8      | 3940   | 4.32   |
| OPA2196IDG4.B | D            | SOIC         | 8    | 75  | 506.6  | 8      | 3940   | 4.32   |
| OPA4196ID     | D            | SOIC         | 14   | 50  | 506.6  | 8      | 3940   | 4.32   |
| OPA4196ID.B   | D            | SOIC         | 14   | 50  | 506.6  | 8      | 3940   | 4.32   |





- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE TRANSISTOR



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE PACKAGE



PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE



- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.



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